





program(s) used to refine structure: *OSCAIL* and *SHELXL97* (Sheldrick, 1997); molecular graphics: *PLATON* (Spek, 2003); software used to prepare material for publication: *SHELXL97* and *PRPKAPPA* (Ferguson, 1999).

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Supplementary data for this paper are available from the IUCr electronic archives (Reference: SK1736). Services for accessing these data are described at the back of the journal.

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# supporting information

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## N-(4-Fluorophenyl)-4-nitrophthalimide: tripartite hydrogen-bonded sheets

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### Computing details

Data collection: *COLLECT* (Hooft, 1999); cell refinement: *DENZO* (Otwinowski & Minor, 1997) and *COLLECT*; data reduction: *DENZO* and *COLLECT*; program(s) used to solve structure: *OSCAIL* (McArdle, 2003) and *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *OSCAIL* and *SHELXL97* (Sheldrick, 1997); molecular graphics: *PLATON* (Spek, 2003); software used to prepare material for publication: *SHELXL97* and *PRPKAPPA* (Ferguson, 1999).

### N-(4-Fluorophenyl)-4-nitrophthalimide

#### Crystal data

$C_{14}H_7FN_2O_4$   
 $M_r = 286.22$   
Monoclinic,  $P2_1$   
Hall symbol: P 2yb  
 $a = 3.7492 (13)$  Å  
 $b = 6.9376 (14)$  Å  
 $c = 23.099 (8)$  Å  
 $\beta = 90.118 (11)^\circ$   
 $V = 600.8 (3)$  Å<sup>3</sup>  
 $Z = 2$

$F(000) = 292$   
 $D_x = 1.582 \text{ Mg m}^{-3}$   
Mo  $K\alpha$  radiation,  $\lambda = 0.71073$  Å  
Cell parameters from 1099 reflections  
 $\theta = 3.5\text{--}25.0^\circ$   
 $\mu = 0.13 \text{ mm}^{-1}$   
 $T = 120$  K  
Plate, yellow  
 $0.15 \times 0.08 \times 0.02$  mm

#### Data collection

Bruker-Nonius 95mm CCD camera on  $\kappa$ -goniostat diffractometer  
Radiation source: Bruker-Nonius FR591 rotating anode  
Graphite monochromator  
Detector resolution: 9.091 pixels mm<sup>-1</sup>  
 $\varphi$  and  $\omega$  scans  
Absorption correction: multi-scan (*SADABS*; Sheldrick, 2003)

$T_{\min} = 0.976$ ,  $T_{\max} = 0.997$   
4455 measured reflections  
1099 independent reflections  
757 reflections with  $I > 2\sigma(I)$   
 $R_{\text{int}} = 0.114$   
 $\theta_{\max} = 25.0^\circ$ ,  $\theta_{\min} = 3.5^\circ$   
 $h = -4 \rightarrow 4$   
 $k = -7 \rightarrow 7$   
 $l = -27 \rightarrow 27$

#### Refinement

Refinement on  $F^2$   
Least-squares matrix: full  
 $R[F^2 > 2\sigma(F^2)] = 0.070$   
 $wR(F^2) = 0.154$   
 $S = 1.06$   
1099 reflections  
190 parameters  
1 restraint  
Primary atom site location: structure-invariant direct methods

Secondary atom site location: difference Fourier map  
Hydrogen site location: inferred from neighbouring sites  
H-atom parameters constrained  
 $w = 1/[\sigma^2(F_o^2) + (0.0761P)^2]$   
where  $P = (F_o^2 + 2F_c^2)/3$   
 $(\Delta/\sigma)_{\max} < 0.001$   
 $\Delta\rho_{\max} = 0.26 \text{ e } \text{\AA}^{-3}$   
 $\Delta\rho_{\min} = -0.24 \text{ e } \text{\AA}^{-3}$





